

Si4542DY

30V Complementary PowerTrench®MOSFET

General Description

This complementary MOSFET device is produced using Fairchild's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

Applications

- DC/DC converter
- Power management

Features

Q1: N-Channel

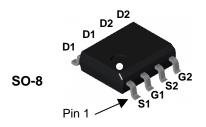
6 A, 30 V $R_{DS(on)} = 28 \ m\Omega \ @ \ V_{GS} = 10 V$

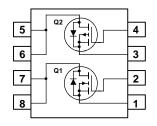
 $R_{DS(on)}$ = 35 m Ω @ V_{GS} = 4.5V

• Q2: P-Channel

-6 A, -30 V $R_{DS(on)} = 32 \text{ m}\Omega @ V_{GS} = -10 \text{V}$

 $R_{DS(on)} = 45 \text{ m}\Omega$ @ $V_{GS} = -4.5V$





Absolute Maximum Ratings $T_A = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter		Q1	Q2	Units
V _{DSS}	Drain-Source Voltage		30	-30	V
V _{GSS}	Gate-Source Voltage		±20	±20	V
I _D	Drain Current - Continuous	(Note 1a)	6	-6	А
	- Pulsed		20	-20	
P _D	Power Dissipation for Dual Operation		:	2	W
	Power Dissipation for Single Operation	(Note 1a)	1	.6	
	(Note 1b)		1	.2	
		(Note 1c)		1	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		–55 to	+175	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	40	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
4542	Si4542DY	13"	12mm	2500 units

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Cha	racteristics			-			
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ $V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	Q1 Q2	30 -30			V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$, Referenced to 25°C $I_D = -250 \mu\text{A}$, Referenced to 25°C	Q1 Q2		23 –21		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V V _{DS} = -24 V, V _{GS} = 0 V	Q1 Q2			1 –1	μΑ
I _{GSS}	Gate-Body Leakage	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$ $V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	Q1 Q2			<u>+</u> 100 <u>+</u> 100	nA
On Cha	racteristics (Note 2)	<u>. </u>					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$ $V_{DS} = V_{GS}, I_D = -250 \mu A$	Q1 Q2	1 -1	1.5 -1.7	3 -3	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C I_D = -250 μA, Referenced to 25°C	Q1 Q2		-4 4		mV/°(
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 6 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 6 \text{ A}, T_J = 125^{\circ}\text{C}$ $V_{GS} = 4.5 \text{ V}, I_D = 5 \text{ A}$	Q1		19 32 25	28 48 35	mΩ
		$V_{GS} = -10 \text{ V}, I_D = -6 \text{ A}$ $V_{GS} = -10 \text{ V}, I_D = -6 \text{ A}, T_J = 125^{\circ}\text{C}$ $V_{GS} = -4.5 \text{ V}, I_D = -5 \text{ A}$	Q2		21 29 30	32 51 45	
I _{D(on)}	On-State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$ $V_{GS} = -10 \text{ V}, V_{DS} = -5 \text{ V}$	Q1 Q2	20 –20			Α
g FS	Forward Transconductance	$V_{DS} = 15 \text{ V}, I_{D} = 6 \text{ A}$ $V_{DS} = -10 \text{ V}, I_{D} = -6 \text{ A}$	Q1 Q2		18 16		S
Dynami	c Characteristics						
C _{iss}	Input Capacitance	Q1 V _{DS} = 15 V, V _{GS} = 0 V,	Q1 Q2		830 1540		pF
C _{oss}	Output Capacitance	f = 1.0 MHz Q2	Q1 Q2		185 400		pF
C _{rss}	Reverse Transfer Capacitance	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz	Q1 Q2		80 170		pF

Electrical	Characteristics	(continued)	T _A = 25°C unless otherwise noted
		(oonenaoa)	I A = 20 C dilless chief wise ficted

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Switchir	ng Characteristics (No	ee 2)					
t _{d(on)}	Turn-On Delay Time	Q1 V _{DS} = 15 V, I _D = 1 A,	Q1 Q2		6 13	12 24	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V$, $R_{GEN} = 6 \Omega$	Q1 Q2		10 22	18 35	ns
t _{d(off)}	Turn-Off Delay Time	Q2 $V_{DS} = -15 \text{ V}, I_{D} = -1 \text{ A},$	Q1 Q2		18 47	29 75	ns
t _f	Turn-Off Fall Time	$V_{GS} = -10 \text{ V}, R_{GEN} = 6 \Omega$	Q1 Q2		5 18	12 30	ns
Qg	Total Gate Charge	Q1 V _{DS} = 15 V, I _D = 7.5 A, V _{GS} = 5 V	Q1 Q2		9 15	13 20	nC
Q_{gs}	Gate-Source Charge	Q2	Q1 Q2		2.8 4		nC
Q_{gd}	Gate-Drain Charge	$V_{DS} = -10 \text{ V}, I_{D} = -6 \text{ A}, V_{GS} = -5 \text{V}$	Q1 Q2		3.1 5		nC

Drain-Source Diode Characteristics and Maximum Ratings							
Is	Maximum Continuous Drain-Source Diode Forward Current	Q1		1.3	Α		
		Q2		-1.3			
V _{SD}	Drain-Source Diode Forward $V_{GS} = 0 \text{ V}, I_S = 1.3 \text{ A}$ (Note 2)	Q1	0.7	1.2	V		
	Voltage $V_{co} = 0 \text{ V} \cdot I_{c} = -1.3 \text{ A} \cdot \text{(Note 2)}$	Ω2	-0.7	-12			

Notes:

 R_{8JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{8JC} is guaranteed by design while R_{8CA} is determined by the user's board design.



a) 78°C/W when mounted on a 0.5 in² pad of 2 oz copper



b) 125°C/W when mounted on a .02 in² pad of 2 oz copper



c) 135°C/W when mounted on a minimum pad.

Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width < 300μ s, Duty Cycle < 2.0%

Si4542DY Rev A

TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

$ACEx^{TM}$	FAST ®	PACMAN™	SuperSOT™-3
Bottomless™	FASTr™	POP^{TM}	SuperSOT™-6
CoolFET™	GlobalOptoisolator™	PowerTrench ®	SuperSOT™-8
CROSSVOLT TM	GTO™	QFET™	SyncFET™
DenseTrench™	HiSeC™	QS™	TinyLogic™
DOME™	ISOPLANAR™	QT Optoelectronics™	UHC TM
EcoSPARK™	LittleFET™	Quiet Series™	UltraFET®
E ² CMOS TM	MicroFET™	SILENT SWITCHER ®	VCX^{TM}
EnSigna™	MICROWIRE™	SMART START™	

FACT Quiet SeriesTM
OPTOPLANARTM
Star* PowerTM
StealthTM

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

- 1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.
- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.

Rev. H1